Se	arch	Notes	5

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/634,868	TOMITSUKA ET AL.	
Examiner	Art Unit	
Michael A. Friedhofer	2832	

SEARCHED			
Class	Subclass	Date	Examiner
200	5a,6a,511, 512,516, 517	3/18/2005	MAF
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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